MCK-005.25-US

Appendix A In the Claims:

- 1. (canceled)
- 2. (canceled)
- (canceled)
- 4. (canceled)
- 5. (canceled)
- 6. (canceled)
- 7. (canceled)
- 8. (canceled)
- 9. (canceled)
- 10. (canceled)
- 11. (canceled)
- 12. (canceled)
- 13. (canceled)
- 14. (canceled)
- 15. (canceled)
- 16. (canceled)
- 17. (canceled)
- 18. (canceled)
- 19. (canceled)
- 20. (previously added) A method of making a dielectric layer between a pair of opposing electrodes comprising the steps of:

forming, as said dielectric layer, an epitaxial thin film on a textured substrate;

forming one of said electrodes on an exposed surface of said thin film;

wholly or partially removing said textured substrate; and

forming an electrical connection to access said dielectric layer on the side of said textured substrate.

- (previously added) The method according to Claim 20 wherein the textured substrate comprises nickel.
- 22. (previously added) The method according to Claim 22 wherein said epitaxial thin film is formed from perovskite.
- 23. (New) The method of claim 20, wherein said thin film is formed of a ferroelectric material.
- (New) The method of claim 20, wherein said epitaxial thin film comprises substantially a single crystal.
- 25. (New) The method of claim 20, wherein at least one of said electrodes is formed by being directly deposited on the surface of said thin film.

MCK-005.25-US

- 26. (New) The method of claim 20, wherein the dielectric has high permittivity.
- 27. (New) The method of claim 20, wherein an insulator is formed onto parts of the side of the textured substrate.
- 28. (New) The method of claim 20, further comprising the step of embedding the dielectric layer within a printed wiring board.
- 29. (New) The method of claim 20, further comprising the step of forming the dielectric layer as part of a discrete capacitor.
- (New) The method of claim 20, further comprising forming the dielectric layer as part of a tunable filter
- 31. (New) The method of claim 20, further comprising forming the dielectric layer as part of a phase shifter
- 32. (New) The method of claim 20, wherein the dielectric is barium strontium titanate.
- 33. (New) The method of claim 20, wherein the dielectric can transmit oxygen.
- 34. (New) The method of claim 20, wherein the dielectric is a zirconate or cerate.
- 35. (New) The method of claim 20, wherein at least one electrode is a conductive oxide.
- 36. (New) The method of claim 20, wherein at least one electrode is a cermet.

MCK-005.25-US

Appendix B

Claim	Recitation	In Application	In Publication (paragraph)
23	ferroelectric	Page 11, line 2	26
24	Single Crystal thin film	Page 17, line 10	52
25	Electrode directly deposited on thin film	Page 15, lines 23-24	48
26	High Permittivity	Page 11, line 2	26
27 DROP	DRÓP	DROP	DROP
28 (change)	Embedding (capacitor)	Page 10, line 29, Page 11, line 6	25 26
29	Discrete capacitor	Page 10, lines 28-29	25
30	Tunable Filter	Page 11, lines 8-10	26
31	Phase Shifter	Page 11, lines 7-8	26
32	Barium Strontium Titanate	Page 21, line 20	63
33	Diclectric transmits oxygen	Page 17, line 19,	52
		Page 24, line 9	Abstract
34	Zirconate, cerate	Page 10, lines 9-10	23
35 DROP	DROP	DROP	DROP
36	Electrode a cermet	Page 18, line 21	51